

Notice of References Cited	Application/Control No. 10/814,173		Applicant(s)/Patent Under Reexamination WANG ET AL.	
	Examiner IRIANA CRUZ		Art Unit 2625	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0131115 A1	07-2004	Burgess et al.	375/240.01
*	B	US-2003/0123093 A1	07-2003	Hattori, Toshiyuki	358/3.06
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP2002027249	01-2002	Japan	Abe Yoshito	H04N 1/405
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

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